	Application No.		Applicant(s)	
Notice of Allowability			(ppriodin(o)	
	09/578,798		PORIS, JAIME Art Unit	
	Examiner	1	art Onit	
	William C. Choi	2	2873	
The MAILING DATE of this communication appeal claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIOF the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) Cl or other appropria IGHTS. This applic	OSED in this application w	cation. If not include ill be mailed in due o	ed course. THIS
 This communication is responsive to <u>Applicant's Responses</u> The allowed claim(s) is/are <u>1-19</u>. The drawings filed on <u>16 October 2002</u> are accepted by the Acknowledgment is made of a claim for foreign priority und 	e Examiner.	9(a)-(d) or (f).		
a) All b) Some* c) None of the:	Ū	.,,,,,,		
 Certified copies of the priority documents have 	e been received.			
Certified copies of the priority documents have	e been received in a	Application No	<u> </u>	
Copies of the certified copies of the priority do	cuments have beer	n received in this na	tional stage applicat	ion from the
International Bureau (PCT Rule 17.2(a)).				
* Certified copies not received:				
5. Acknowledgment is made of a claim for domestic priority u			al application).	
(a) The translation of the foreign language provisional a	• •			
6. Acknowledgment is made of a claim for domestic priority u	nger 35 U.S.C. 99	120 and/or 121.		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of below. Failure to timely comply will result in ABANDONMENT of				
7. A SUBSTITUTE OATH OR DECLARATION must be submINFORMAL PATENT APPLICATION (PTO-152) which gives reas				IOTICE OF
 8. CORRECTED DRAWINGS must be submitted. (a) including changes required by the Notice of Draftsper 1) hereto or 2) to Paper No. (b) including changes required by the proposed drawing (c) including changes required by the attached Examiner 	correction filed	, which has bee	n approved by the E	
Identifying indicia such as the application number (see 37 CFR 1 each sheet.	.84(c)) should be wr	itten on the drawings	in the front (not the	back) of
9. DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT FOR T	sit of BIOLOGICA THE DEPOSIT OF I	AL MATERIAL mu BIOLOGICAL MATE	st be submitted. N RIAL.	lote the
Attachment(s)				
1⊠ Notice of References Cited (PTO-892) 3□ Notice of Draftperson's Patent Drawing Review (PTO-948) 5⊠ Information Disclosure Statements (PTO-1449), Paper No	8/4/2003 6 6 8 8 9 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	Interview Summary Examiner's Amend	Patent Application (F (PTO-413), Paper ment/Comment ent of Reasons for A	No

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Allowed Claims: 1-19.

REASONS FOR ALLOWANCE

The following is an examiner's statement of reasons for allowance: none of the

prior art either alone or in combination disclose or teach of the claimed combination of

limitations to warrant a rejection under 35 USC 102 or 103.

Specifically, with respect to independent claim 1, none of the prior art alone or in

combination disclose or teach of a method of measuring dishing as claimed, specifically

comprising generating a set of calibration data; measuring the height variation of a first

feature on a substrate and correlating the height variation of the first feature with the

calibration data as claimed.

Specifically, with respect to independent claim 14, none of the prior art alone or

in combination disclose or teach of a method of producing a set of calibration data for

comparing to the measured height variation of a first feature as claimed, specifically

comprising providing at least one sample substrate having a plurality of first features

having differing widths and exhibiting dishing, surrounded by a second feature,

measuring the magnitude of the dishing of the plurality of the first features and relating

the magnitude of dishing to at least on of the first feature widths and the profile shape of

the first features.

Specifically, with respect to independent claim 17, none of the prior art alone or

in combination disclose or teach of a method of measuring dishing in a first feature as

claimed, specifically comprising measuring the height variation of a first feature

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embedded in a second feature, to determine the profile shape of the first feature and comparing the height variation of the first feature with pre-generated calibration data that relates the magnitude of dishing to the profile shape of a first feature.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

CITATION OF RELEVANT PRIOR ART

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Johnson et al (U.S. 6,623,991 B2) is being cited herein to show a method, which can be used to measure dishing, but does not specifically disclose the calibration data or profile shape limitations of that of the claimed invention.

CONCLUSION

Any inquiry concerning this communication or earlier communications from the examiner should be directed to William C. Choi whose telephone number is (703) 305-3100. The examiner can normally be reached on Monday-Friday from about 9:00 am to 6 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Georgia Y. Epps can be reached on (703) 308-4883. The fax phone numbers for the organization where this application or proceeding is assigned are (703)

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305-3431 for regular communications and (703) 305-3432 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

William Choi Patent Examiner Art Unit 2873 October 7, 2003

Georgia Epps
Supervisory Patent Examiner
Technology Center 2800

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